

1260

Impedance/gain-phase Analyzer

The 1260 Impedance/gain-phase Analyzer is - without doubt - the most powerful, accurate and flexible Frequency Response Analyzer available today.

In daily use by leading researchers wherever measurement integrity and experimental reliability are of paramount importance, 1260's solid reputation is frequently endorsed in published research papers in fields such as:-

- Corrosion studies
- · Battery research and fuel cells
- Solar cells
- LCDs
- Bio-materials
- Ceramics / composites
- Electronic component development
- · Civil engineering

Part of Solartron Analytical's extensive range of precision products designed to provide cost effective solutions for dc and ac analysis in electrochemical and materials research, 1260 offers an outstanding measurement specification for impedance spectroscopy:

Huge frequency range

Spanning $10\mu Hz$ to 32MHz with 0.015ppm resolution, 1260 provides excellent coverage for virtually all chemical and molecular mechanisms - all in a single instrument.

Unbeatable accuracy

With an accuracy of 0.1%, 0.1°, measurements can be made with complete confidence, and even the most subtle changes in sample behavior detected and quantized.

Noise free analysis

1260 uses Solartron Analytical's patented single-sine correlation technique, which inherently removes the noise and harmonic distortion which plagues lesser instruments.

- Frequency resolution: 1 in 65 million (0.015ppm)
- 0.1%, 0.1° accuracy unsurpassed by any similar instrument
- Resolution to 0.001dB, 0.01° capturing every detail
- Measures impedances >100MΩ
- 2-, 3- and 4-terminal measurement configurations
- Polarization voltage up to ±40.95V
- Renowned ZPlot software package simplifies experiments and optimises throughput

Systems

When combined with other products from Solartron Analytical's range, including well-proven application software, 1260 can form the heart of an advanced electrochemical and materials measurement system, to provide superb accuracy, flexibility and reliability - even for the most complex research problems.

Impedance measurement

Virtually every liquid and solid is able to pass current when a voltage is applied to it. If a variable (ac) voltage is applied to the material, the ratio of voltage to current is known as the impedance. The measured impedance varies with the frequency of the applied voltage in a way that is related to the properties of the liquid or solid. This may be due to the physical structure of the material, to chemical processes within it or a combination of both.

The advantages of impedance measurement over other techniques include:-

- · Rapid aquisition of data
- Accurate, repeatable measurements
- Non-destructive
- Highly adaptable to a wide variety of different applications.
- Ability to differentiate effects due to electrodes, diffusion, mass/charge transfer by analysis over different frequency ranges
- Equivalent circuit/modelling techniques for detailed analysis of results



1260 Impedance/gain-phase Analyzer Specification

Voltage mode

0 to 3V rms

0 to 1V rms

±40.95V

5mV

Generator ac Amplitude ≤10MHz

>10MHz Maximum ac resolution dc bias range Maximum dc resolution

Output impedance

Frequency

Sweep types Maximum voltage Maximum current

Impedance Connection Output disable

Maximum resolution

Inputs protected to

Full scale peak

Connections Shields

Coupling

Input System

Ranges

10mV 200uA 50Ω±1% >200k Ω at <1kHz range: 10μHz to 32MHz, max resolution: 10μHz error: ±100ppm, stability, 24hrs ±1°C: ±10ppm frequency (log or lin), ac/dc voltage, ac/dc current

hi to Io: ±46V peak, Io to ground: ±0.4V peak

Current mode

0 to 60mA rms

0 to 20mA rms

100uA

Current

6μA, 60μA, 600μA, 6mA, 60mA

±100mA

±100mA peak lo to ground: $100k\Omega$, <10nFsingle BNC, floating shield contact closure or TTL logic 0

Voltage (2x)

3 independent analyzers operating in parallel 30mV, 300mV, 3V

1Mohm, <35pF

10kohm, 330pF

200pA 1μV ±5V ±100mA ±46V ±250mA single/differential BNC single BNC

floating/grounded

dc or ac (-3dB at 1Hz) dc or ac (-3dB at Hz)

Input impedance

Hi to shield

Shield to ground

Limits of error

Ambient temperature 20±10°C, integration time >200ms.

Data valid for one year after calibration.

Results

Variable Measured parameters

Power supply Power consumption

Dimensions (w x h x d)

Weight

Operating temp, range

Limit of error Gain-phase measurements Applies to all ranges

at >10% full scale

frequency, ac amplitude, dc bias

voltage gain, phase, real, imaginary, Z, R, X, Y, G, B, V, I group delay, C, L, Q, D

≥600µA range, 1Ω

<600 μ A range, 50Ω

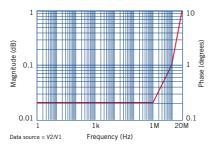
90 to 126V, 198 to 252V, 48 to 65Hz

230VA

432mm x 176mm x 573mm (17in x 6.93in x 22.56in)

18kg (40lbs)

0 to 50°C (32 to 122°F)



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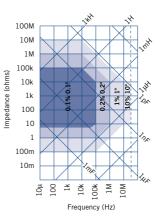
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Impedance Measurements

Applies for stimulation level of 1V for impedances $>50\Omega$ or 20mA for impedances <50 Ω



Solartron Analytical is a world leader in instrumentation and software for the characterization of materials and electrochemical systems using precision electrical measurement techniques.

These techniques find particular use in the fields of corrosion, battery and fuel cell research, dielectric analysis and electrochemistry. The product portfolio includes industry standard frequency response analyzers, potentiostats, electrochemical software (Zplot and CorrWare) and battery test equipment.

Arun Technology, an operating unit of Solartron Analytical, provides a range of metal analyzers using optical emission techniques for determining elemental content. The units in static laboratory or mobile format are used in foundries, steelworks, or scrapyards for metals analysis or material identification.



